Lecture6

Sung-Min Hong (smhong@gist.ac.kr)

Semiconductor Device Simulation Lab.

School of Electrical Engineering and Computer Science
Gwangju Institute of Science and Technology

Gate potential

- Let us assume that $V_G = 0 \text{ V}$.
 - However, the electrostatic potential is <u>NOT</u> 0 V at that point.
 - For the gate metal, the workfunction is known. The workfunction is the energy difference between the vacuum level and the Fermi level.
 - Therefore, when the workfunction is 4.3 eV, the vacuum level is located at 4.3 eV, because the Fermi level is the energy reference.
 - Moreover, the energy difference between the vacuum level and the intrinsic Fermi level of silicon is given. (About 4.63 eV)
 - Then, the intrinsic Fermi level of silicon is located at -0.33 eV.
 - Finally, the electrostatic potential is 0.33 V.

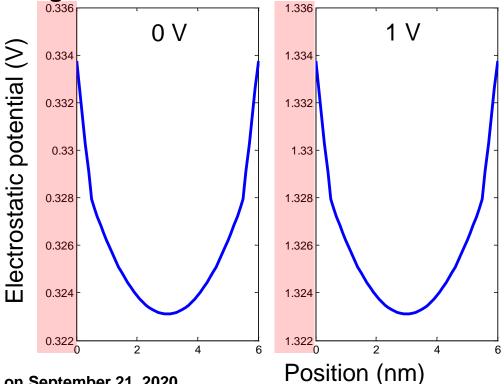
Double-gate MOS revisited

- Now apply the realistic boundary condition.
 - With the gate metal whose workfunction is 4.3 eV, the boundary value of the electrostatic potential is 0.33374 V.

- Solve the same problem. Neglect the carrier densities.
- The gate voltage varies from 0 V to 1 V.

Results at $V_G = 0 \text{ V}$ and 1 V

- Can you find something wrong?
 - Depletion approximation?



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Electron density (1)

- Effective density-of-states of the conduction band, N_C
 - For example, N_C of silicon at 300 K is about 2.86X10¹⁹ cm⁻³.
- Electron density
 - Assume the Boltzmann statistics.
 - At equilibrium, the electron density can be obtained by

$$n(\mathbf{r}) = N_C \exp\left(\frac{E_F - E_C}{k_B T}\right)$$

 E_F : Fermi level, E_C : Conduction band minimum

 k_R : Boltzmann constant, T: Temperature

- At 300 K, $k_B T$ ≈ 25.85 meV.

Electron density (2)

• Remember that $E_F = 0$. Then,

$$n(\mathbf{r}) = N_C \exp\left(-\frac{E_C}{k_B T}\right)$$

- Also, the energy difference between E_C and E_i is a given constant.

$$n(\mathbf{r}) = N_C \exp\left(-\frac{E_C}{k_B T}\right) = N_C \exp\left(-\frac{E_C - E_i + E_i}{k_B T}\right)$$

- Using $E_i = -q\phi$, we can obtain

$$n(\mathbf{r}) = N_C \exp\left(-\frac{E_C - E_i}{k_B T}\right) \exp\left(\frac{q\phi}{k_B T}\right) = n_i \exp\left(\frac{q\phi}{k_B T}\right) = n_i \exp\left(\frac{\phi}{V_T}\right)$$

MATLAB example (1)

- Step-by-step procedure
 - First, set up the structure.

```
q = 1.602192e-19; % Elementary charge, C
eps0 = 8.854187817e-12; % Vacuum permittivity, F/m
k B = 1.380662e-23; % Boltzmann constant, J/K
T = 300.0; % Temperature, K
Deltax = 0.1e-9; % 0.1 nm spacing
N = 61; % 6 nm thick
x = Deltax*transpose([0:N-1]); % real space, m
interface1 = 6; % At x=0.5 nm
interface2 = 56; % At x=5.5 nm
eps_si = 11.7; eps_ox = 3.9; % Relative permittivity
Nacc = 1e24; % 1e18 /cm<sup>3</sup>
ni = 1.075e16; % 1.075e10 /cm^3
```

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MATLAB example (2)

- Step-by-step procedure (continued)
 - Next, set the matrix, A. (Five cases)

```
A = zeros(N,N);
A(1,1) = 1.0;
for ii=2:N-1
    if     (ii< interface1) A(ii,ii-1) = eps_ox; A(ii,ii) = -2*eps_ox; A(ii,ii+1) = eps_ox;
    elseif (ii==interface1) A(ii,ii-1) = eps_ox; A(ii,ii) = -eps_ox-eps_si; A(ii,ii+1) = eps_si;
    elseif (ii< interface2) A(ii,ii-1) = eps_si; A(ii,ii) = -2*eps_si; A(ii,ii+1) = eps_si;
    elseif (ii==interface2) A(ii,ii-1) = eps_si; A(ii,ii) = -eps_si-eps_ox; A(ii,ii+1) = eps_ox;
    elseif (ii> interface2) A(ii,ii-1) = eps_ox; A(ii,ii) = -2*eps_ox; A(ii,ii+1) = eps_ox;
    end
end
A(N,N) = 1.0;
```

MATLAB example (3)

The vector, b, has the correct boundary values.

• Get the solution, phi.

```
phi = A \setminus b;
```

MATLAB example (4)

Using phi, the electron density is estimated.

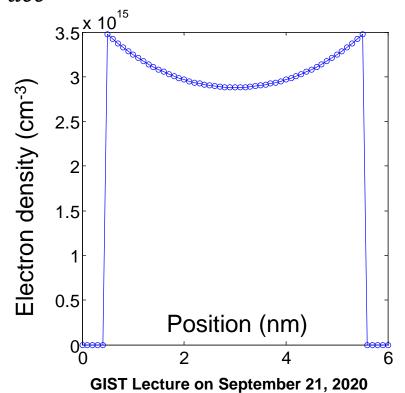
```
elec = zeros(N,1);
for ii=interface1:interface2
   elec(ii,1) = ni * exp(q*phi(ii,1)/(k_B*T));
end
```

Plot it!

```
plot(x/1e-9, elec*1e-6);
```

MATLAB example (5)

• Graph with $N_{acc} = 10^{18} \text{ cm}^{-3}$



Homework#6

- Due: AM08:00, September 23 (This Wednesday)
- Problem#1
 - Write your own code for the double-gate structure, whose oxide thickness is 0.8 nm.
 - The electrostatic potential is obtained under the depletion approximation. (The initial potential) The electron density is calculated by assuming $n_i \exp\left(\frac{q\phi}{k_BT}\right)$. Then, using the electron density, re-calculate the potential. (The updated potential)
 - Check their difference for several gate voltages from 0 V to 1 V.
 (The voltage step is 0.1 V. 11 points in total.)